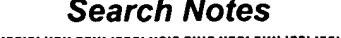


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/716,257	AARON ET AL.
	Examiner	Art Unit
	John Q. Nguyen	3654

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner